# Power MOSFET and Schottky Diode

## 30 V, 5.7 A, Single N-Channel with 30 V, 2.8 A, Schottky Barrier Diode

#### **Features**

- FETKY™ Surface Mount Package Saves Board Space
- Independent Pin-Out for MOSFET and Schottky Allowing for Design Flexibility
- Low R<sub>DS(on)</sub> MOSFET and Low V<sub>F</sub> Schottky to Minimize Conduction Losses
- Optimized Gate Charge to Minimize Switching Losses
- This is a Pb-Free Device

#### **Applications**

- Disk Drives
- DC-DC Converters
- Printers

#### MOSFET MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise stated)

Ratir	Symbol	Value	Unit		
Drain-to-Source Voltage	)		V <sub>DSS</sub>	30	V
Gate-to-Source Voltage			$V_{GS}$	±20	V
Continuous Drain		T <sub>A</sub> = 25°C	I <sub>D</sub>	4.7	Α
Current R <sub>θJA</sub> (Note 1)		T <sub>A</sub> = 70°C		3.8	
Power Dissipation R <sub>0</sub> JA (Note 1)		T <sub>A</sub> = 25°C	P <sub>D</sub>	1.6	W
Continuous Drain		T <sub>A</sub> = 25°C	I <sub>D</sub>	3.3	Α
Current R <sub>θJA</sub> (Note 2)	Steady	T <sub>A</sub> = 70°C		2.6	
Power Dissipation R <sub>0</sub> JA (Note 2)	State	T <sub>A</sub> = 25°C	P <sub>D</sub>	0.77	W
Continuous Drain		T <sub>A</sub> = 25°C	I <sub>D</sub>	5.7	Α
Current $R_{\theta JA}$ t < 10 s (Note 1)		T <sub>A</sub> = 70°C		4.5	
Power Dissipation R <sub>θJA</sub> t < 10 s (Note 1)		T <sub>A</sub> = 25°C	P <sub>D</sub>	2.3	W
Pulsed Drain Current		= 25°C, = 10 μs	I <sub>DM</sub>	19	Α
Operating Junction and Storage Temperature			T <sub>J</sub> , T <sub>STG</sub>	-55 to +150	°C
Source Current (Body Diode)			I <sub>S</sub>	1.3	Α
Lead Temperature for So (1/8" from case for 10 s)		urposes	TL	260	°C

#### **SCHOTTKY MAXIMUM RATINGS** (T<sub>J</sub> = 25°C unless otherwise stated)

Peak Repetitive Reverse Voltage	$V_{RRM}$	30	V	
DC Blocking Voltage		$V_R$	30	V
Average Rectified Forward Current, (Note 1)	Steady State	I <sub>F</sub>	2.8	Α
	t < 10 s		4.1	



#### ON Semiconductor®

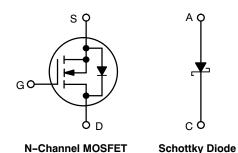
http://onsemi.com

#### **N-CHANNEL MOSFET**

V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> Max	I <sub>D</sub> Max
30 V	48 mΩ @ 10 V	5.7 A
	70 m $\Omega$ @ 4.5 V	<b>5</b> 7.

#### SCHOTTKY DIODE

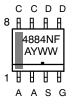
V <sub>R</sub> Max	V <sub>F</sub> Max	I <sub>F</sub> Max
30 V	0.5 V	2.8 A



### MARKING DIAGRAM & PIN ASSIGNMENT



SOIC-8 CASE 751 STYLE 18



4884NF = Device Code

A = Assembly Location
Y = Year
WW = Work Week
Pb-Free Package

#### ORDERING INFORMATION

Device	Package	Shipping <sup>†</sup>
NTMD4884NFR2G	SOIC-8 (Pb-Free)	2500/Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

#### THERMAL RESISTANCE MAXIMUM RATINGS

Parameter MOSFET & Schottky	Symbol	Max	Unit
Junction-to-Ambient - Steady State (Note 1)	$R_{ heta JA}$	79	
Junction-to-Ambient – t ≤10 s Steady State (Note 1)	$R_{ heta JA}$	54	°C/W
Junction-to-FOOT (Drain) Equivalent to $R_{\theta JC}$	$R_{ heta JF}$	50	°C/VV
Junction-to-Ambient - Steady State (Note 2)	$R_{ heta JA}$	163	

- Surface-mounted on FR4 board using 1 inch sq pad size, 1 oz Cu.
   Surface-mounted on FR4 board using the minimum recommended pad size.

#### **ELECTRICAL CHARACTERISTICS** (T<sub>1</sub> = 25°C unless otherwise noted)

Characteristic	Symbol	Test Co	ndition	Min	Тур	Max	Unit
OFF CHARACTERISTICS				•		•	
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	V <sub>GS</sub> = 0 V, I <sub>I</sub>	ο = 250 μΑ	30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>				24		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V,	T <sub>J</sub> = 25°C			1.0	μА
		$V_{DS} = 24 \text{ V}$	T <sub>J</sub> = 125°C			20	μΑ
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$				±100	nA
ON CHARACTERISTICS (Note 3)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D = 250 \mu A$		1.0		2.5	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				5.0		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 4.0 A		34	48	m0
		V <sub>GS</sub> = 4.5 V	I <sub>D</sub> = 3.5 A		50	70	mΩ
Forward Transconductance	9FS	V <sub>DS</sub> = 5.0 V, I <sub>D</sub> = 4.0 A			10		S
Gate Resistance	$R_{G}$				2.4	3.6	Ω
CHARGES, CAPACITANCES AND GATE RE	SISTANCE						
Input Capacitance	C <sub>ISS</sub>	$V_{GS} = 0 \text{ V, f} = 1.0 \text{ MHz,}$ $V_{DS} = 15 \text{ V}$			280	360	
Output Capacitance	C <sub>OSS</sub>				60	80	pF
Reverse Transfer Capacitance	C <sub>RSS</sub>				32	42	7
Total Gate Charge	Q <sub>G(TOT)</sub>				2.8	4.2	
Threshold Gate Charge	Q <sub>G(TH)</sub>	$V_{GS} = 4.5 \text{ V}, V_{DS} = 15 \text{ V},$ $I_D = 4.0 \text{ A}$			0.4		nC
Gate-to-Source Charge	$Q_{GS}$				1.2		
Gate-to-Drain Charge	$Q_{GD}$				1.0		1
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 10 V, \ I <sub>D</sub> = 4			5.6	8.0	nC
SWITCHING CHARACTERISTICS (Note 4)					_		
Turn-On Delay Time	$t_{d(ON)}$				6.0	12	
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = 10 V, \	/ <sub>DS</sub> = 15 V,		6.5	13	1
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$I_{D} = 1.0 \text{ A, F}$			14	26	ns
Fall Time	t <sub>f</sub>				1.4	7.0	7
DRAIN-TO-SOURCE CHARACTERISTICS							
Forward Diode Voltage	$V_{SD}$	V <sub>GS</sub> = 0 V	T <sub>J</sub> = 25°C		0.8	1.0	V
		I <sub>D</sub> = 1.3 A	T <sub>J</sub> = 125°C		0.65	1	
Reverse Recovery Time	t <sub>RR</sub>				9.2	20	1
Charge Time	t <sub>a</sub>	$V_{GS} = 0 \text{ V}, d_{IS}/c$	d <sub>t</sub> = 100 A/us,		6.0		ns
Discharge Time	t <sub>b</sub>	I <sub>S</sub> = 4	.0 A		3.2		
Reverse Recovery Time	Q <sub>RR</sub>				3.3		nC

#### **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise noted)

Characteristic	Symbol		Test Condition	Min	Тур	Max	Unit
COUNTRY/ DIODE ELECTRICAL CHARACTERISTICS (T. 0500 virtues atherwise material)							

SCHOLINI DIODE ELECTRICAL CHARACTERISTICS (1) = 23 C unless ou	TTKY DIODE ELECTRICAL CHARACTERISTICS (T, = 25°C unless otherwise noted)
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Parameter	Symbol	Test Con	ditions	Min	Тур	Max	Unit
Maximum Instantaneous	V <sub>F</sub>	I <sub>F</sub> = 0.1 A	T <sub>J</sub> = 25°C		0.26	0.28	V
Forward Voltage			T <sub>J</sub> = 125°C		0.11	0.13	
		I <sub>F</sub> = 2.0 A	T <sub>J</sub> = 25°C		0.4	0.50	
			T <sub>J</sub> = 125°C		0.35	0.46	
Maximum Instantaneous	I <sub>R</sub>	V <sub>R</sub> = 10 V	T <sub>J</sub> = 25°C		0.020	0.25	mA
Reverse Current			T <sub>J</sub> = 125°C		10	37	

- 3. Pulse Test: pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2%.
- 4. Switching characteristics are independent of operating junction temperatures.

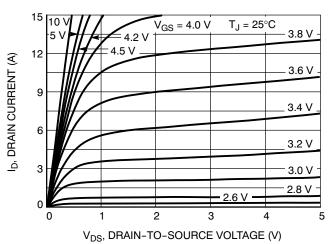


Figure 1. On-Region Characteristics

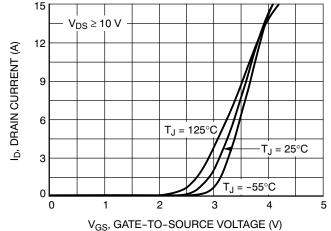


Figure 2. Transfer Characteristics

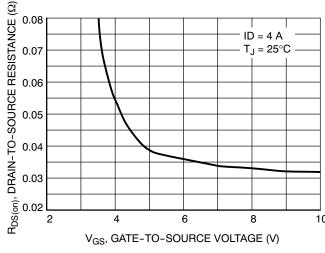


Figure 3. On-Resistance vs. Gate Voltage

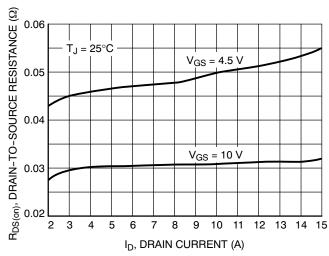


Figure 4. On-Resistance vs. Drain Current and Gate Voltage

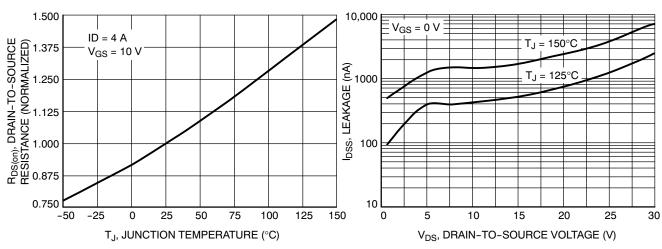


Figure 5. On–Resistance Variation with Temperature

Figure 6. Drain-to-Source Leakage Current vs. Voltage

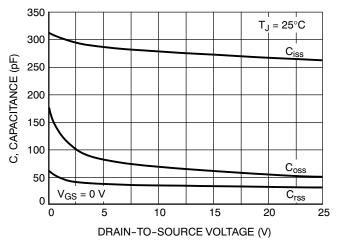


Figure 7. Capacitance Variation

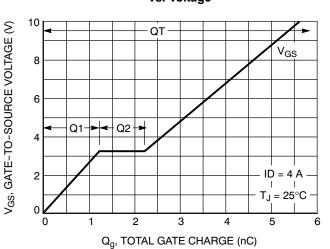


Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

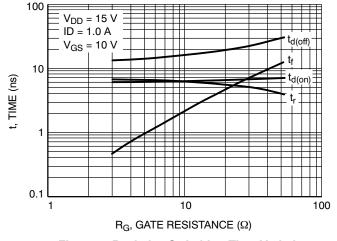


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

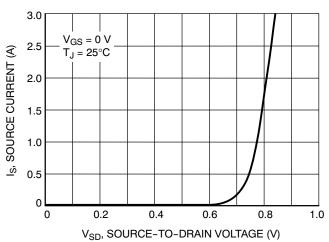


Figure 10. Diode Forward Voltage vs. Current

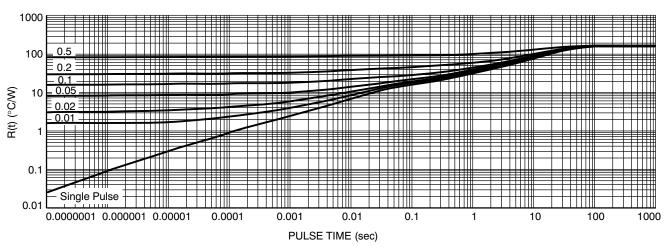


Figure 11. Thermal Response –  $R_{\theta JA}$  at Steady State (min pad)

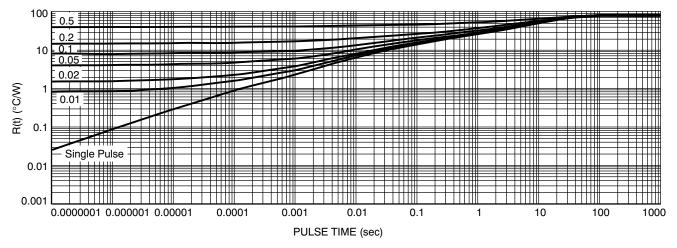


Figure 12. Thermal Response –  $R_{\theta JA}$  at Steady State (1 inch sq pad)

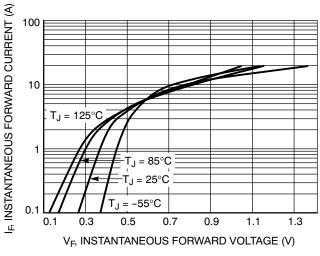


Figure 13. Typical Forward Voltage

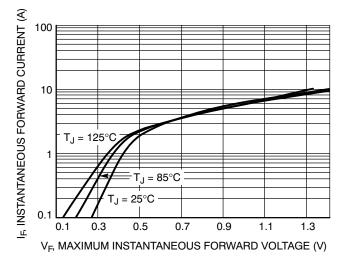


Figure 14. Maximum Forward Voltage

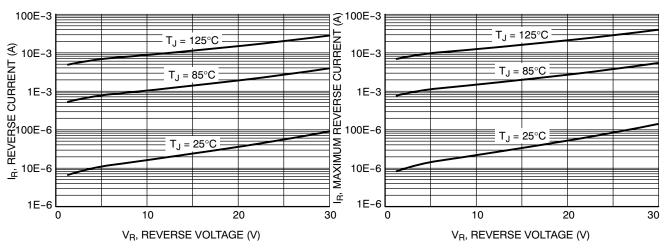


Figure 15. Typical Reverse Current

Figure 16. Maximum Reverse Current

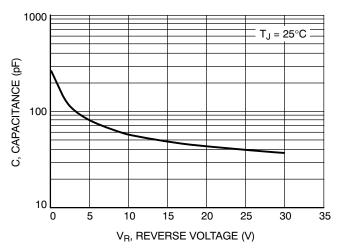


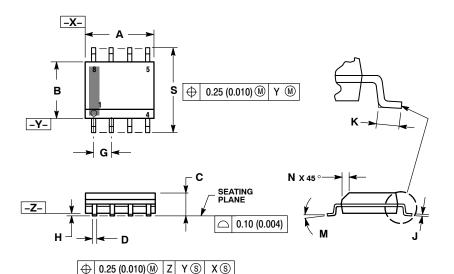
Figure 17. Capacitance





#### SOIC-8 NB CASE 751-07 **ISSUE AK**

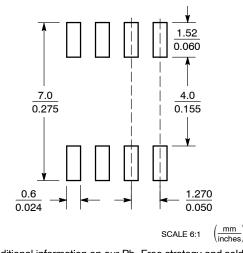
**DATE 16 FEB 2011** 



- NOTES:
  1. DIMENSIONING AND TOLERANCING PER
- ANSI Y14.5M, 1982.
  CONTROLLING DIMENSION: MILLIMETER.
- DIMENSION A AND B DO NOT INCLUDE MOLD PROTRUSION.
- MAXIMUM MOLD PROTRUSION 0.15 (0.006) PER SIDE
- DIMENSION D DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.127 (0.005) TOTAL IN EXCESS OF THE D DIMENSION AT MAXIMUM MATERIAL CONDITION.
- 751-01 THRU 751-06 ARE OBSOLETE. NEW STANDARD IS 751-07.

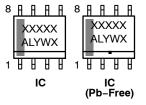
	MILLIMETERS		INC	HES
DIM	MIN	MAX	MIN	MAX
Α	4.80	5.00	0.189	0.197
В	3.80	4.00	0.150	0.157
С	1.35	1.75	0.053	0.069
D	0.33	0.51	0.013	0.020
G	1.27	1.27 BSC		0 BSC
Н	0.10	0.25	0.004	0.010
J	0.19	0.25	0.007	0.010
K	0.40	1.27	0.016	0.050
М	0 °	8 °	0 °	8 °
N	0.25	0.50	0.010	0.020
S	5.80	6.20	0.228	0.244

#### **SOLDERING FOOTPRINT\***



<sup>\*</sup>For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

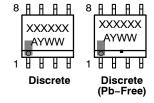
#### **GENERIC MARKING DIAGRAM\***



XXXXX = Specific Device Code = Assembly Location

= Wafer Lot = Year = Work Week W

= Pb-Free Package



XXXXXX = Specific Device Code = Assembly Location Α

= Year ww = Work Week

= Pb-Free Package

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

#### **STYLES ON PAGE 2**

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#### SOIC-8 NB CASE 751-07 ISSUE AK

#### **DATE 16 FEB 2011**

STYLE 1: PIN 1. EMITTER 2. COLLECTOR 3. COLLECTOR 4. EMITTER 5. EMITTER 6. BASE 7. BASE 8. EMITTER	STYLE 2: PIN 1. COLLECTOR, DIE, #1 2. COLLECTOR, #1 3. COLLECTOR, #2 4. COLLECTOR, #2 5. BASE, #2 6. EMITTER, #2 7. BASE, #1 8. EMITTER, #1	STYLE 3: PIN 1. DRAIN, DIE #1 2. DRAIN, #1 3. DRAIN, #2 4. DRAIN, #2 5. GATE, #2 6. SOURCE, #2 7. GATE, #1 8. SOURCE, #1	STYLE 4: PIN 1. ANODE 2. ANODE 3. ANODE 4. ANODE 5. ANODE 6. ANODE 7. ANODE 8. COMMON CATHODE
STYLE 5: PIN 1. DRAIN 2. DRAIN 3. DRAIN 4. DRAIN 5. GATE 6. GATE 7. SOURCE 8. SOURCE	STYLE 6: PIN 1. SOURCE 2. DRAIN 3. DRAIN 4. SOURCE 5. SOURCE 6. GATE 7. GATE 8. SOURCE	STYLE 7: PIN 1. INPUT 2. EXTERNAL BYPASS 3. THIRD STAGE SOURCE 4. GROUND 5. DRAIN 6. GATE 3 7. SECOND STAGE Vd 8. FIRST STAGE Vd	STYLE 8: PIN 1. COLLECTOR, DIE #1 2. BASE. #1
STYLE 9: PIN 1. EMITTER, COMMON 2. COLLECTOR, DIE #1 3. COLLECTOR, DIE #2 4. EMITTER, COMMON 5. EMITTER, COMMON 6. BASE, DIE #2 7. BASE, DIE #1 8. EMITTER, COMMON	STYLE 10: PIN 1. GROUND 2. BIAS 1 3. OUTPUT 4. GROUND 5. GROUND 6. BIAS 2 7. INPUT 8. GROUND	STYLE 11: PIN 1. SOURCE 1 2. GATE 1 3. SOURCE 2 4. GATE 2 5. DRAIN 2 6. DRAIN 2 7. DRAIN 1 8. DRAIN 1	STYLE 12: PIN 1. SOURCE 2. SOURCE 3. SOURCE 4. GATE 5. DRAIN 6. DRAIN 7. DRAIN 8. DRAIN
STYLE 13: PIN 1. N.C. 2. SOURCE 3. SOURCE 4. GATE 5. DRAIN 6. DRAIN 7. DRAIN 8. DRAIN	STYLE 14: PIN 1. N-SOURCE 2. N-GATE 3. P-SOURCE 4. P-GATE 5. P-DRAIN 6. P-DRAIN 7. N-DRAIN 8. N-DRAIN	STYLE 15:  PIN 1. ANODE 1 2. ANODE 1 3. ANODE 1 4. ANODE 1 5. CATHODE, COMMON 6. CATHODE, COMMON 7. CATHODE, COMMON 8. CATHODE, COMMON	STYLE 16: PIN 1. EMITTER, DIE #1 2. BASE, DIE #1 3. EMITTER, DIE #2 4. BASE, DIE #2 5. COLLECTOR, DIE #2 6. COLLECTOR, DIE #2 7. COLLECTOR, DIE #1 8. COLLECTOR, DIE #1
STYLE 17: PIN 1. VCC 2. V2OUT 3. V1OUT 4. TXE 5. RXE 6. VEE 7. GND 8. ACC	STYLE 18: PIN 1. ANODE 2. ANODE 3. SOURCE 4. GATE 5. DRAIN 6. DRAIN 7. CATHODE 8. CATHODE	STYLE 19: PIN 1. SOURCE 1 2. GATE 1 3. SOURCE 2 4. GATE 2 5. DRAIN 2 6. MIRROR 2 7. DRAIN 1 8. MIRROR 1	STYLE 20: PIN 1. SOURCE (N) 2. GATE (N) 3. SOURCE (P) 4. GATE (P) 5. DRAIN 6. DRAIN 7. DRAIN 8. DRAIN
STYLE 21: PIN 1. CATHODE 1 2. CATHODE 2 3. CATHODE 3 4. CATHODE 4 5. CATHODE 5 6. COMMON ANODE 7. COMMON ANODE 8. CATHODE 6	STYLE 22: PIN 1. I/O LINE 1 2. COMMON CATHODE/VCC 3. COMMON CATHODE/VCC 4. I/O LINE 3 5. COMMON ANODE/GND 6. I/O LINE 4 7. I/O LINE 5 8. COMMON ANODE/GND	STYLE 23: PIN 1. LINE 1 IN 2. COMMON ANODE/GND 3. COMMON ANODE/GND 4. LINE 2 IN 5. LINE 2 OUT 6. COMMON ANODE/GND 7. COMMON ANODE/GND 8. LINE 1 OUT	STYLE 24: PIN 1. BASE 2. EMITTER 3. COLLECTOR/ANODE 4. COLLECTOR/ANODE 5. CATHODE 6. CATHODE 7. COLLECTOR/ANODE 8. COLLECTOR/ANODE
STYLE 25: PIN 1. VIN 2. N/C 3. REXT 4. GND 5. IOUT 6. IOUT 7. IOUT 8. IOUT	STYLE 26: PIN 1. GND 2. dv/dt 3. ENABLE 4. ILIMIT 5. SOURCE 6. SOURCE 7. SOURCE 8. VCC	STYLE 27: PIN 1. ILIMIT 2. OVLO 3. UVLO 4. INPUT+ 5. SOURCE 6. SOURCE 7. SOURCE 8. DRAIN	STYLE 28: PIN 1. SW_TO_GND 2. DASIC_OFF 3. DASIC_SW_DET 4. GND 5. V_MON 6. VBULK 7. VBULK 8. VIN
STYLE 29: PIN 1. BASE, DIE #1 2. EMITTER, #1 3. BASE, #2 4. EMITTER, #2 5. COLLECTOR, #2 6. COLLECTOR, #2 7. COLLECTOR, #1 8. COLLECTOR, #1	STYLE 30: PIN 1. DRAIN 1 2. DRAIN 1 3. GATE 2 4. SOURCE 2 5. SOURCE 1/DRAIN 2 6. SOURCE 1/DRAIN 2 7. SOURCE 1/DRAIN 2 8. GATE 1		

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